

# TXN/TYN 0512 ---> TXN/TYN 1012

**SCR** 

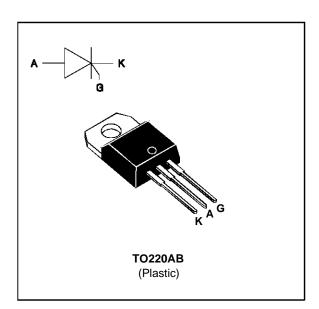
#### **FEATURES**

- HIGH SURGE CAPABILITY
- HIGH ON-STATE CURRENT
- HIGH STABILITY AND RELIABILITY
- TXN Serie: INSULATED VOLTAGE = 2500V<sub>(RMS)</sub> (UL RECOGNIZED: E81734)

#### **DESCRIPTION**

The TYN/TXN 0512 ---> TYN/TXN 1012 Family of Silicon Controlled Rectifiers uses a high performance glass passivated technology.

This general purpose Family of Silicon Controlled Rectifiers is designed for power supplies up to 400Hz on resistive or inductive load.



### **ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter	Value	Unit		
I <sub>T</sub> (RMS)	RMS on-state current TXN (180° conduction angle) TXN		Tc=80°C Tc=90°C	12	А
lT(AV)	Average on-state current (180° conduction angle,single phase circuit)	Tc=80°C Tc=90°C	8	А	
ITSM				125	A
	( Tj initial = 25°C )		tp=10 ms	120	
l <sup>2</sup> t	I <sup>2</sup> t value tp=10 ms			72	A <sup>2</sup> s
dI/dt	Critical rate of rise of on-state current Gate supply: IG = 100 mA dig/dt = 1 A/µs	100	A/μs		
Tstg Tj	Storage and operating junction temperature range			- 40 to + 150 - 40 to + 125	°C °C
TI	Maximum lead temperature for soldering during 10 s at 4.5 mm from case			260	°C

Symbol	Parameter		TYN/TXN					Unit	
		0512	112	212	412	612	812	1012	
VDRM VRRM	Repetitive peak off-state voltage Tj = 125 °C	50	100	200	400	600	800	1000	٧

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### THERMAL RESISTANCES

Symbol	Parameter	Value	Unit	
Rth (j-a)	Junction to ambient		60	°C/W
Rth (j-c) DC	(j-c) DC Junction to case for DC TXN		3.5	°C/W
		TYN	2.5	

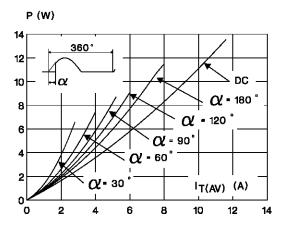
## **GATE CHARACTERISTICS** (maximum values)

 $P_{G (AV)} = 1W$   $P_{GM} = 10W (tp = 20 \ \mu s)$   $I_{FGM} = 4A (tp = 20 \ \mu s)$   $V_{RGM} = 5 \ V.$ 

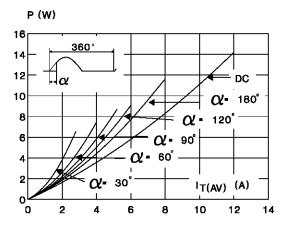
# **ELECTRICAL CHARACTERISTICS**

Symbol	Test Conditions	Value	Unit		
IGT	$V_D=12V$ (DC) $R_L=33\Omega$	Tj=25°C	MAX	15	mA
V <sub>GT</sub>	$V_D=12V$ (DC) $R_L=33\Omega$	Tj=25°C	MAX	1.5	V
$V_{GD}$	$V_D=V_{DRM}$ R <sub>L</sub> =3.3k $\Omega$	Tj= 125°C	MIN	0.2	V
tgt	$V_D=V_{DRM}$ $I_G=40$ mA $dI_G/dt=0.5$ A/ $\mu$ s	Tj=25°C	TYP	2	μs
ΙL	IG= 1.2 IGT	Tj=25°C	TYP	50	mA
lн	I <sub>T</sub> = 100mA gate open	Tj=25°C	MAX	30	mA
VTM	ITM= 24A tp= 380μs	Tj=25°C	MAX	1.6	V
IDRM	V <sub>DRM</sub> Rated	Tj=25°C	MAX	0.01	mA
IRRM	VRRM Rated	Tj= 125°C		3	
dV/dt	Linear slope up to V <sub>D</sub> =67%V <sub>DRM</sub> gate open	Tj= 125°C	MIN	200	V/μs
tq	V <sub>D</sub> =67%V <sub>DRM</sub> I <sub>TM</sub> = 24A V <sub>R</sub> = 25V dI <sub>TM</sub> /dt=30 A/μs dV <sub>D</sub> /dt= 50V/μs	Tj= 125°C	TYP	70	μs

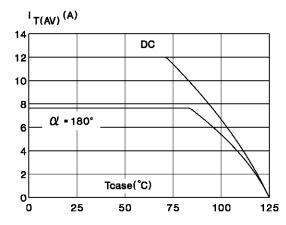
**Fig.1**: Maximum average power dissipation versus average on-state current (TXN).



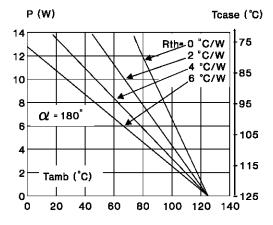
**Fig.3**: Maximum average power dissipation versus average on-state current (TYN).



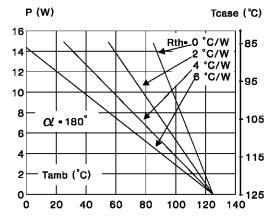
**Fig.5**: Average on-state current versus case temperature (TXN).



**Fig.2**: Correlation between maximum average power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact (TXN).



**Fig.4**: Correlation between maximum average power dissipation and maximum allowable temperatures ( $T_{amb}$  and  $T_{case}$ ) for different thermal resistances heatsink + contact (TYN).



**Fig.6**: Average on-state current versus case temperature (TYN).

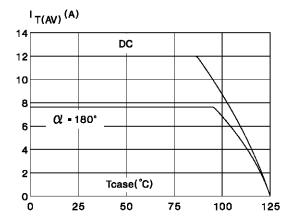


Fig.7: Relative variation of thermal impedance versus pulse duration.

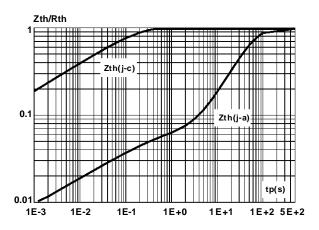


Fig.9: Non repetitive surge peak on-state current versus number of cycles.

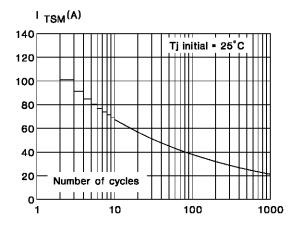
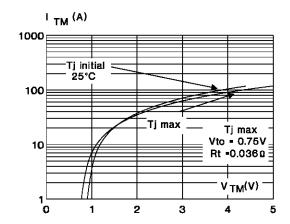
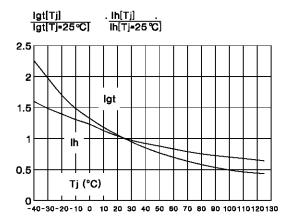


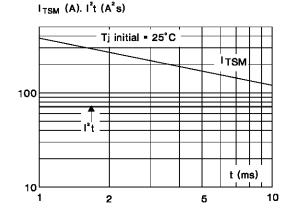
Fig.11: On-state characteristics (maximum values).



**Fig.8**: Relative variation of gate trigger current versus junction temperature.

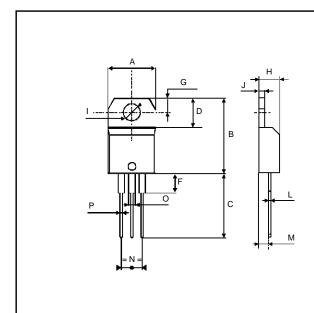


**Fig.10 :** Non repetitive surge peak on-state current for a sinusoidal pulse with width :  $t \le 10$  ms, and corresponding value of  $l^2t$ .



#### PACKAGE MECHANICAL DATA

TO220AB Plastic



REF.	DIMENSIONS					
	Millimeters		Inc	hes		
	Min. Max.		Min.	Max.		
Α	10.00	10.40	0.393	0.409		
В	15.20	15.90	0.598	0.625		
С	13.00	14.00	0.511	0.551		
D	6.20	6.60	0.244	0.259		
F	3.50	4.20	0.137	0.165		
G	2.65	2.95	0.104	0.116		
Н	4.40	4.60	0.173	0.181		
I	3.75	3.85	0.147	0.151		
J	1.23	1.32	0.048	0.051		
L	0.49	0.70	0.019	0.027		
М	2.40	2.72	0.094	0.107		
N	4.80	5.40	0.188	0.212		
0	1.14	1.70	0.044	0.066		
Р	0.61	0.88	0.024	0.034		

Cooling method: by conduction (method C)

Marking: type number Weight: 2.3 g

Recommended torque value : 0.8 m.N. Maximum torque value : 1 m.N.

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